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Substitute for form 1449A/PTO				Complete if Known		
				Application Number	10/797,231	
II.	IFORMATION	1 DI	SCLOSURE	Filing Date	March 10, 2004	
S	TATEMENT E	3Y /	APPLICANT	First Named Inventor	Matthew T. Currie	
				Art Unit	2812	
	(Use as many sheets as necessary)			Examiner Name	A. G. Ghyka	
Sheet	1	of	2	Attorney Docket Number ASC-057C1		

	U.S. PATENT DOCUMENTS							
Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (<i>if known</i>)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
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	A72*	US-5,981,400	11-09-1999	Lo				
	A73*	US-6,074,919	06-13-2000	Gardner et al.				
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Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁵ (# known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	T [€]		
	B1	EP-0 587 520	03-16-1994					
	B2	JP-2000-031491	01-28-2000					

Examiner	Date	
Signature	/Alexander Ghyka/ (12/10/2008)Considered	

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. * CITE NO.: Those application(s) which are marked with an single asterisk (*) next to the Cite No. are not supplied (under 37 CFR 1.98(a)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IFW. 'Applicant's unique citation designation number (optional). * See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. * Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). * For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. * Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. * Applicant is to place a check mark here if English language Translation is attached.

/Alexander Ghyka/ (12/10/2008)

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Substitute for form 1449/PTO				Complete if Known		
				Application Number	10/797,231	
II.	NFORMATION	1 DI	SCLOSURE	Filing Date	March 10, 2004	
S	TATEMENT E	3Y /	APPLICANT	First Named Inventor	Richard Hammond	
				Art Unit	2812	
	(Use as many sheets as necessary)			Examiner Name	A. G. Ghyka	
Sheet	2	of	2	Attorney Docket Number	ASC-057C1	

		NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²		
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Examiner		Date	
Signature	/Alexander Ghvka/ (12/10/2008)	Considered	

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/Alexander Ghyka/ (12/10/2008)

Applicant's unique citation designation number (optional). ²Applicant is to place a check mark here if English language Translation is attached.